

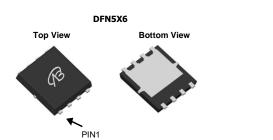
P-Channel 60 V (D-S) MOSFET

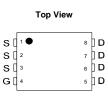
PRODUCT SUMMARY					
V _{DS} (V)	-60				
$R_{DS(on)}(\Omega)$ at $V_{GS} = -10 \text{ V}$	0.050				
$R_{DS(on)}(\Omega)$ at $V_{GS} = -4.5 \text{ V}$	0.060				
I _D (A) per leg	-30				

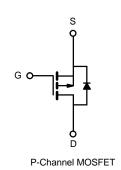
FEATURES

- TrenchFET® power MOSFET
- 100 % R_g and UIS tested









ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage		V _{DS}	-60	V		
Gate-Source Voltage	V _{GS}	V _{GS} ± 20				
Continuous Drain Current	T _C = 25 °C	1	-30			
	T _C = 100 °C	- I _D	-24			
Continuous Source Current (Diode Conduc	I _S	-30	Α			
Pulsed Drain Current ^a	I _{DM}	-90				
Single Pulse Avalanche Current	1 04 mil	I _{AS}	-22.4			
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	25	mJ		
	T _C = 25 °C	D	5	10/		
Maximum Power Dissipation ^a	T _C = 125 °C	P_{D}	1.67	W		
Operating Junction and Storage Temperature Range		T _J , T _{sta}	-55 to +175	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	LIMIT	UNIT		
Junction-to-Ambient	PCB Mount b	R_{thJA}	110	°C/W		
Junction-to-Foot (Drain)		R_{thJF}	30	C/VV		

Notes

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. When mounted on 1" square PCB (FR-4 material).
- c. Parametric verification ongoing.



PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static	•	•				l		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-60	-	-	V	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	V _{DS} = V _{GS} , I _D = -250 μA			-2.5	v	
Gate-Source Leakage	I _{GSS}	V _{DS} =	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$		-	± 100	nA	
		$V_{GS} = 0 V$	V _{DS} = -60 V	-	-	-1		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	V _{DS} = -60 V, T _J = 125 °C	-	-	-50	μΑ	
		$V_{GS} = 0 V$	V _{DS} = -60 V, T _J = 175 °C	-	-	-150		
On-State Drain Current ^a	I _{D(on)}	V _{GS} = -10 V	V _{DS} ≤ -5 V	-30	-	-	Α	
		V _{GS} = -10 V	I _D = -4.3 A	-	0.050	-	Ω	
Durin Co. Co. Clata Bariata and	В	V _{GS} = -10 V	I _D = -4.3 A, T _J = 125 °C	-	0.075	-		
Drain-Source On-State Resistance a	R _{DS(on)}	V _{GS} = -10 V	I _D = -4.3 A, T _J = 175 °C	-	0.125	-		
		V _{GS} = -4.5 V	I _D = -3.8 A	-	0.060	-		
Forward Transconductance b	9 _{fs}	$V_{DS} = -15 \text{ V}, I_D = -4.3 \text{ A}$		-	13	-	S	
Dynamic ^b								
Input Capacitance	C _{iss}			-	1000	-		
Output Capacitance	Coss	$V_{GS} = 0 V$	$V_{DS} = -30 \text{ V}, f = 1 \text{ MHz}$	-	334	417	pF	
Reverse Transfer Capacitance	C _{rss}	7		-	114	142		
Total Gate Charge ^c	Qg			-	43.4	65		
Gate-Source Charge ^c	Q _{gs}	V _{GS} = -10 V	$V_{DS} = -30 \text{ V}, I_{D} = -5 \text{ A}$	-	4.7	-	nC	
Gate-Drain Charge ^c	Q _{gd}			-	9	-		
Gate Resistance	R_g		f = 1 MHz		2.5	4	Ω	
Turn-On Delay Time ^c	t _{d(on)}			-	11	17		
Rise Time ^c	t _r	V_{DD} = -30 V, R_L = 8.8 Ω I_D \cong -5 A, V_{GEN} = -10 V, R_g = 1 Ω		-	11	17	ns	
Turn-Off Delay Time ^c	t _{d(off)}			-	35	52		
Fall Time ^c	t _f			-	6	9		
Source-Drain Diode Ratings and Chara	acteristics ^b	•						
Pulsed Current ^a	I _{SM}			-	-	- 90	Α	
Forward Voltage	V _{SD}	I _F =	I _F = -2.8 A, V _{GS} = 0 V		-0.8	-1.2	V	
<u> </u>				l	1	1		

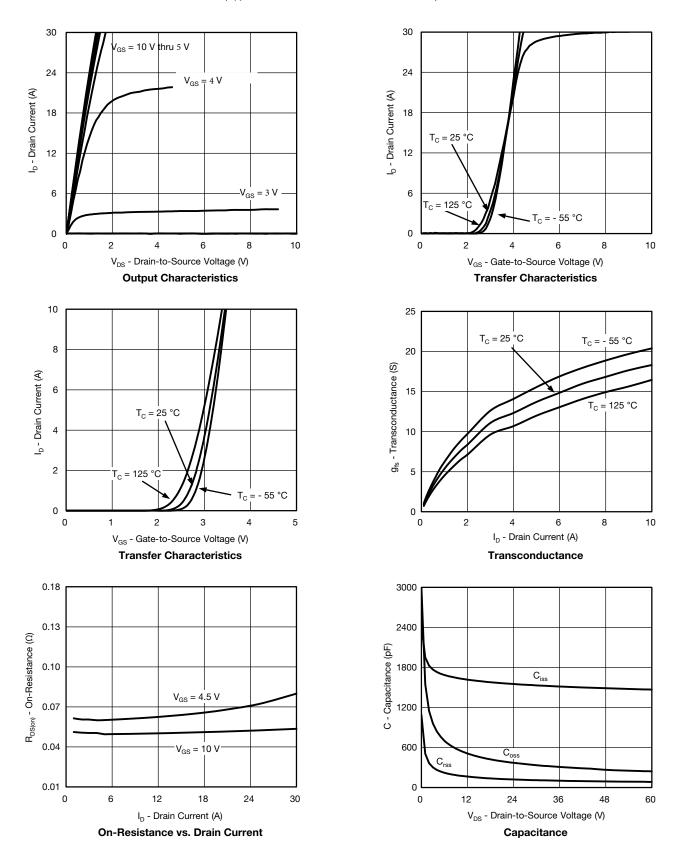
Notes

- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

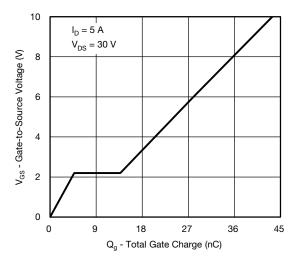


TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)

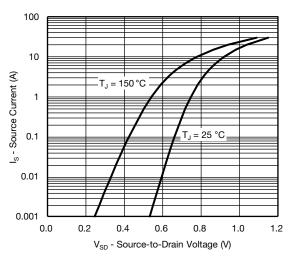




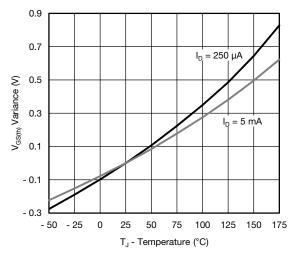
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



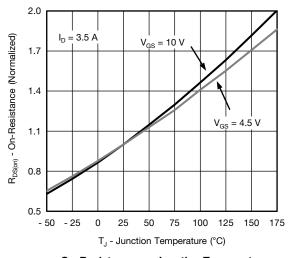
Gate Charge



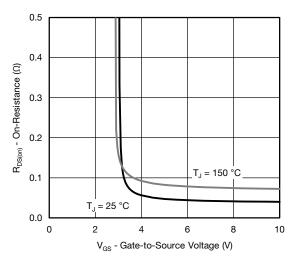
Source Drain Diode Forward Voltage



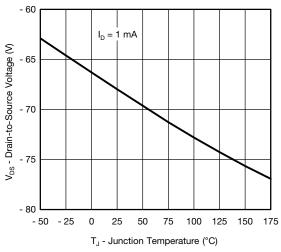
Threshold Voltage



On-Resistance vs. Junction Temperature



On-Resistance vs. Gate-to-Source Voltage

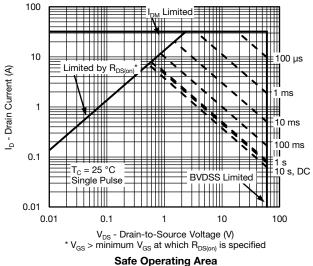


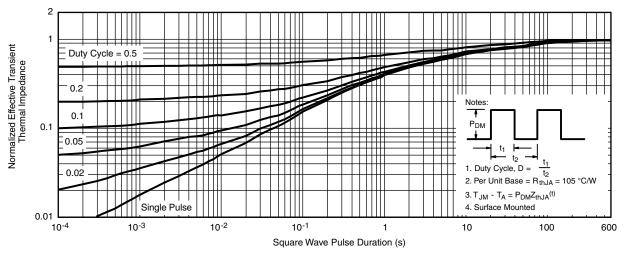
Drain Source Breakdown vs. Junction Temperature

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THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)





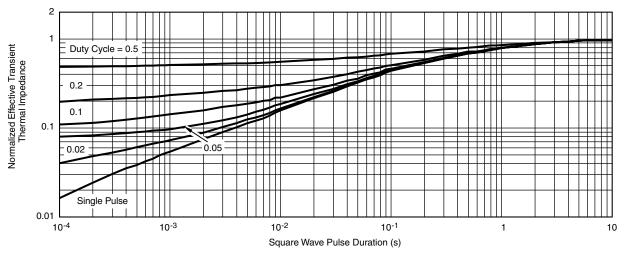
Normalized Thermal Transient Impedance, Junction-to-Ambient

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THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Foot

Note

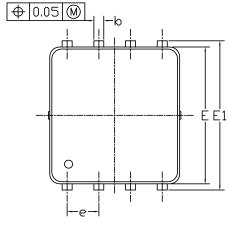
- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)
 - Normalized Transient Thermal Impedance Junction-to-Foot (25 °C)

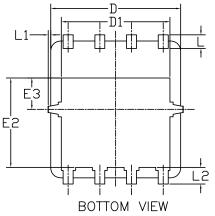
are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.

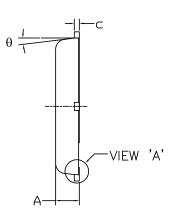
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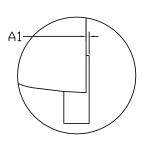


DFN5x6_8L_EP1_P PACKAGE OUTLIN



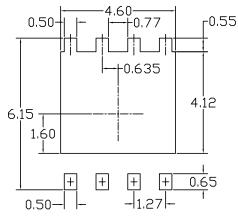






<u>VIEW 'A'</u> (SCALE 5:1)

RECOMMENDED LAND PATTERN



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
SYMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.85	0. 95	1.00	0.033	0.037	0.039	
A1	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
c	0.15	0. 20	0. 25	0.006	0.008	0.010	
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209	
D1	4. 25	4. 35	4. 45	0. 167	0. 171	0. 175	
Е	5. 45	5. 55	5. 65	0. 215	0. 219	0. 222	
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242	
E2	3. 525	3.625	3. 725	0.139	0. 143	0. 147	
E3	1. 175	1. 275	1. 375	0.046	0.050	0.054	
e		1. 27 BSC			0.050 BSC		
L	0.45	0. 55	0.65	0.018	0.022	0.026	
L1	0		0.15	0		0.006	
L2		0.68 REF		0.027 REF			
θ	0°		10°	0°		10°	

NOTE

UNIT: mm

- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT



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